

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/812,983	YAMAOKA ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Hai H. Huynh	3747	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,267,097 B1	07-2001	Urushihara et al.	123/305
	B	US-6,336,436 B1	01-2002	Miyakubo et al.	123/295
	C	US-6,341,487 B1	01-2002	Takahashi et al.	60/286
	D	US-6,352,491 B2	03-2002	Mashiki et al.	477/107
	E	US-6,499,456 B1	12-2002	Nogi et al.	123/295
	F	US-6,739,295 B1	05-2004	Yamaoka et al.	123/90.15
	G	US-6,772,585 B2	08-2004	Iihoshi et al.	60/277
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.